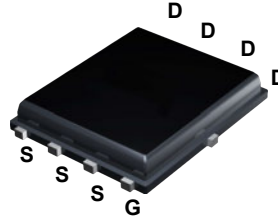
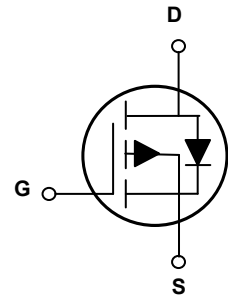


## Main Product Characteristics

$V_{(BR)DSS}$	-100V
$R_{DS(ON)}$	50m $\Omega$ (max.)
$I_D$	-30A



PPAK5x6



Schematic Diagram

## Features and Benefits

- Advanced MOSFET process technology
- Ideal for high efficiency switched mode power supplies
- Low on-resistance with low gate charge
- Fast switching and reverse body recovery



## Description

The GSFP500P10 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supplies and a wide variety of other applications.

## Absolute Maximum Ratings ( $T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Parameter	Unit
Drain-Source Voltage	$V_{DS}$	-100	V
Gate-to-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current, @ Steady-State ( $T_C=25^\circ\text{C}$ )	$I_D$	-30	A
Continuous Drain Current, @ Steady-State ( $T_C=100^\circ\text{C}$ )		-20	A
Pulsed Drain Current ( $T_C=25^\circ\text{C}$ ) <sup>1</sup>	$I_{DM}$	-120	A
Power Dissipation ( $T_C=25^\circ\text{C}$ ) <sup>2</sup>	$P_D$	52	W
Single Pulse Avalanche Energy	$E_{AS}$	289	mJ
Single Pulse Current	$I_{AS}$	-34	A
Junction-to-Ambient (PCB Mounted, Steady-State)	$R_{\theta JA}$	62.0	$^\circ\text{C/W}$
Junction-to-Case	$R_{\theta JC}$	2.4	$^\circ\text{C/W}$
Operating Junction and Storage Temperature Range	$T_J/T_{STG}$	-55 to +150	$^\circ\text{C}$
Soldering Temperature (SMD)	$T_{sold}$	260	$^\circ\text{C}$

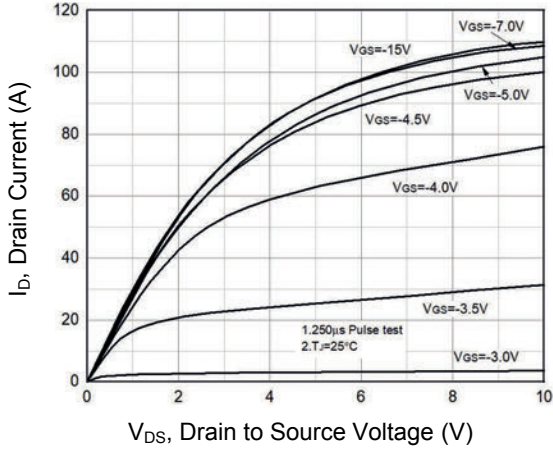
**Electrical Characteristics** ( $T_A=25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
<b>On / Off Characteristics</b>						
Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=-250\mu A$	-100	-	-	V
Drain-to-Source Leakage Current	$I_{DSS}$	$V_{DS}=-100V, V_{GS}=0V, T_J=25^\circ\text{C}$	-	-	-1.0	$\mu A$
		$V_{DS}=-100V, V_{GS}=0V, T_J=125^\circ\text{C}$	-	-1.0	-10	
Gate-to-Source Forward Leakage	$I_{GSS}$	$V_{DS}=0V, V_{GS}=20V$	-	-	100	nA
		$V_{DS}=0V, V_{GS}=-20V$	-	-	-100	
Static Drain-to-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=-10V, I_D=-15A$	-	35	50	m $\Omega$
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=-250\mu A$	-1.5	-	-2.5	V
<b>Dynamic and Switching Characteristics</b>						
Input Capacitance	$C_{iss}$	$V_{GS}=0V, V_{DS}=-25V, f=1\text{MHz}$	-	4440	-	$\mu F$
Output Capacitance	$C_{oss}$		-	233	-	
Reverse Transfer Capacitance	$C_{rss}$		-	144	-	
Total Gate Charge <sup>3,4</sup>	$Q_g$	$I_D=-15A, V_{DD}=-50V, V_{GS}=-10V$	-	80	-	nC
Gate-to-Source Charge <sup>3,4</sup>	$Q_{gs}$		-	19	-	
Gate-to-Drain ("Miller") Charge <sup>3,4</sup>	$Q_{gd}$		-	15	-	
Gate-to-Plateau <sup>3,4</sup>	$V_{plateau}$		-	4.1	-	V
Turn-on Delay Time <sup>3,4</sup>	$t_{d(on)}$	$V_{DD}=-50V, V_{GS}=-10V, R_G=9.1\Omega, I_D=-15A$	-	9.8	-	nS
Rise Time <sup>3,4</sup>	$t_r$		-	41	-	
Turn-Off Delay Time <sup>3,4</sup>	$t_{d(off)}$		-	258	-	
Fall Time <sup>3,4</sup>	$t_f$		-	90	-	
Gate Resistance	$R_g$	$f=1\text{MHz}$	-	12	-	$\Omega$
<b>Source-Drain Ratings and Characteristics</b>						
Continuous Source Current (Body Diode)	$I_S$	MOSFET symbol showing the integral reverse p-n junction diode.	-	-	-30	A
Diode Pulse Current	$I_{S,pulse}$		-	-	-120	A
Diode Forward Voltage	$V_{SD}$	$I_S=-10A, V_{GS}=0V$	-	-	-1.4	V
Reverse Recovery Time <sup>3</sup>	$T_{rr}$	$I_S=-15A, V_{GS}=0V, dI_F/dt=100A/\mu s$	-	31	-	nS
Reverse Recovery Charge <sup>3</sup>	$Q_{rr}$		-	0.05	-	$\mu C$

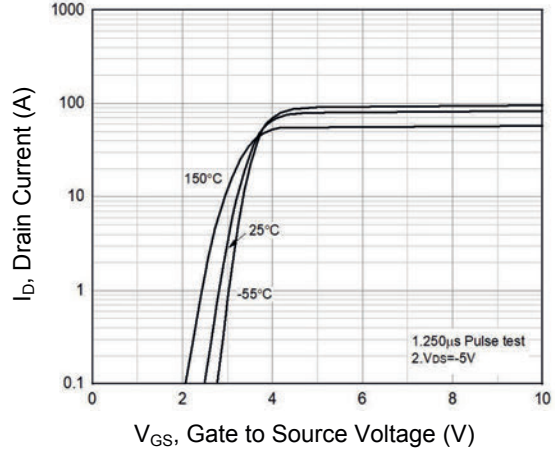
Notes:

1. Pulse time is 5 $\mu s$ .
2. The dissipated power value will change with the temperature. When it is greater than 25 $^\circ\text{C}$ , the dissipated power value will decrease by 0.83 $^\circ\text{C}/\text{W}$  for every 1 degree increase in temperature.
3. Pulse test: Pulse width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$ .
4. Basically unaffected by operating temperature.

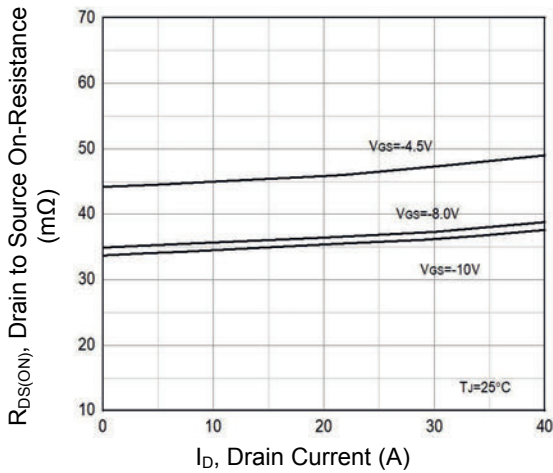
**Typical Electrical and Thermal Characteristic Curves**



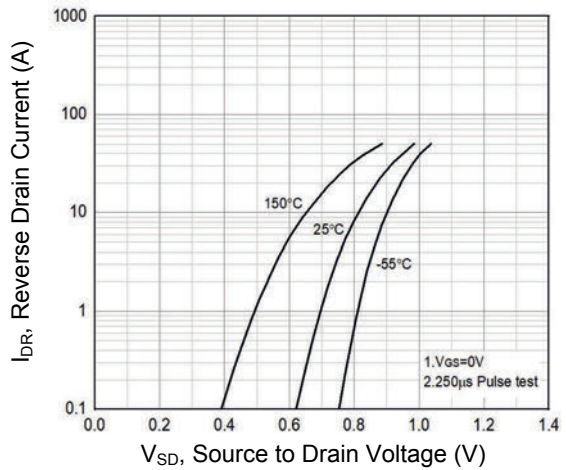
**Figure 1. Typical Output Characteristics**



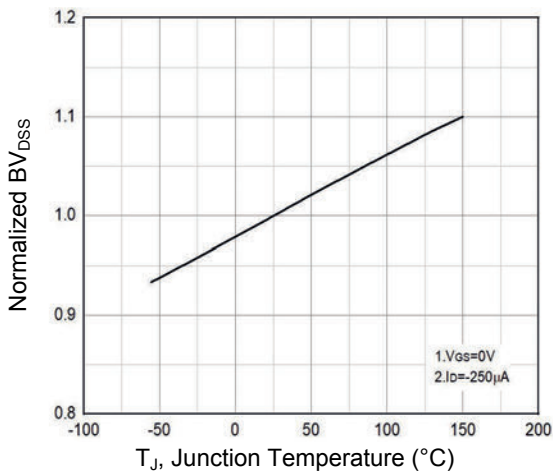
**Figure 2. Transfer Characteristics**



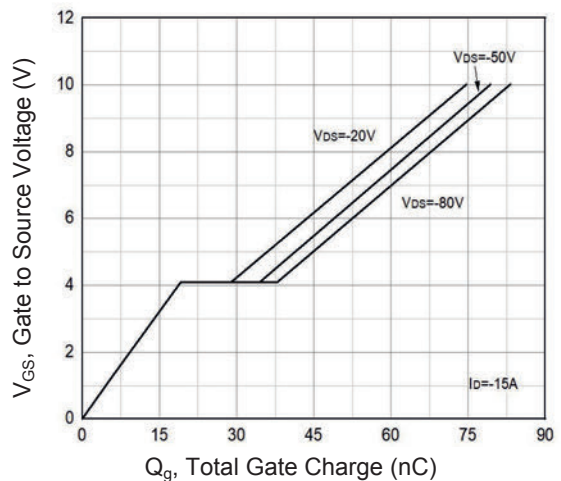
**Figure 3.  $R_{DS(ON)}$  vs. Drain Current**



**Figure 4. Body Diode Characteristics**

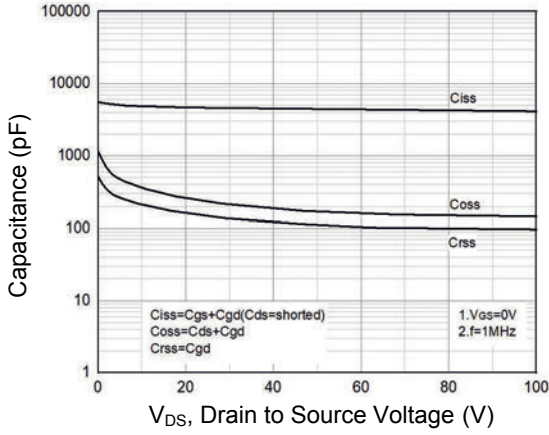


**Figure 5. Normalized  $BV_{DSS}$  vs.  $T_J$**

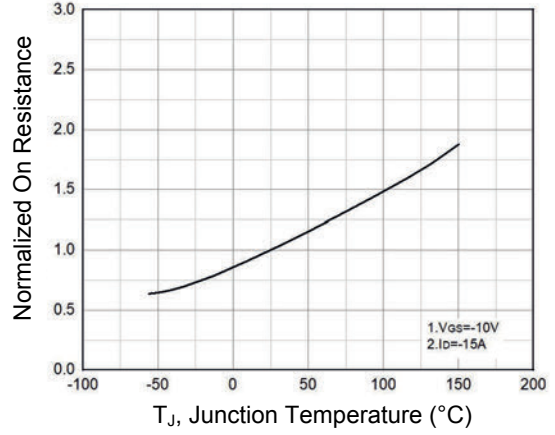


**Figure 6. Gate Charge**

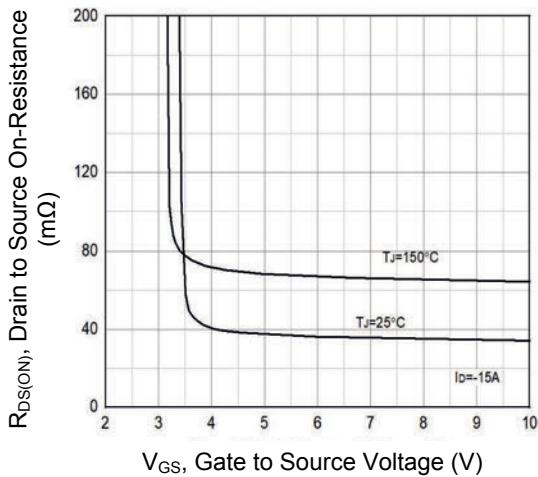
**Typical Electrical and Thermal Characteristic Curves**



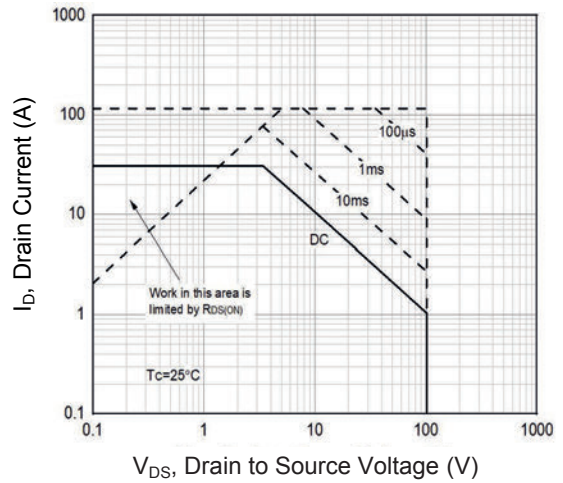
**Figure 7. Capacitance Characteristics**



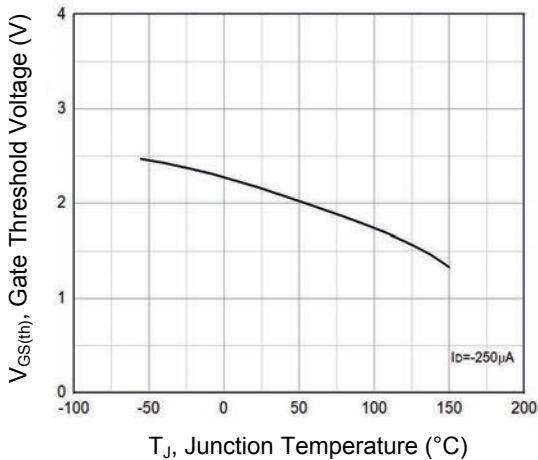
**Figure 8. Normalized  $R_{DS(ON)}$  vs.  $T_J$**



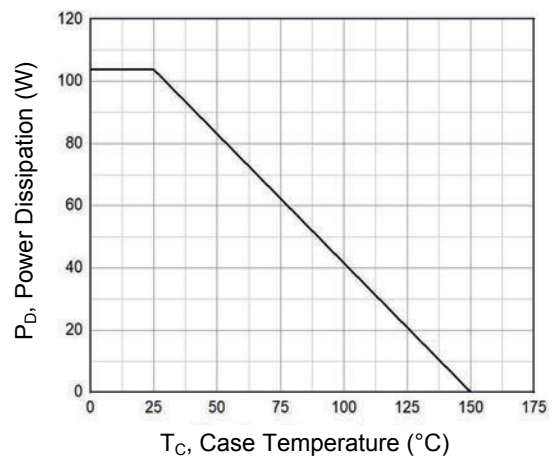
**Figure 9.  $R_{DS(ON)}$  vs.  $V_{GS}$**



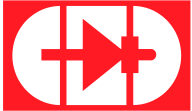
**Figure 10. Safe Operation Area**



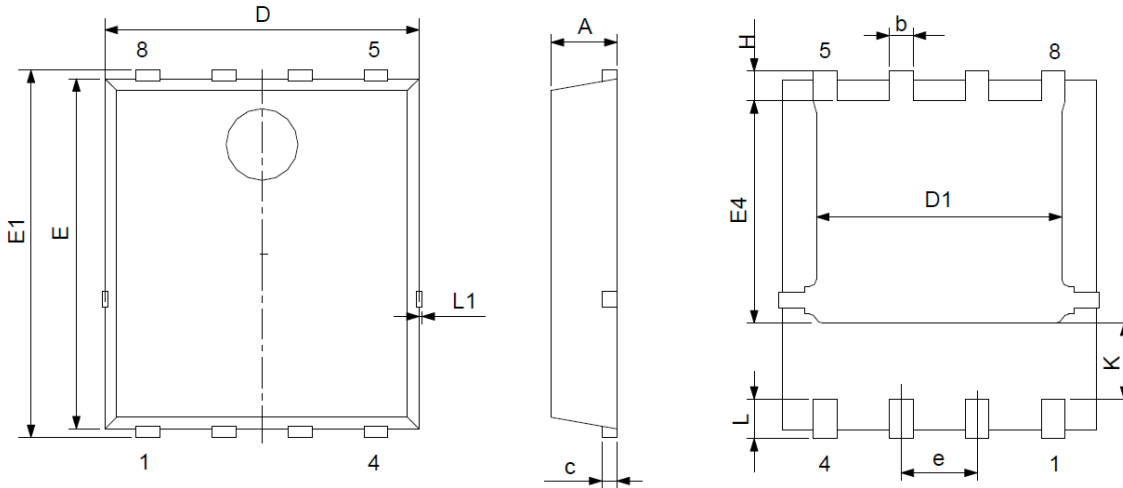
**Figure 11. Gate Threshold Voltage vs.  $T_J$**



**Figure 12. Power Dissipation vs.  $T_C$**



**Package Outline Dimensions (PPAK5x6)**



Symbol	Dimensions in Millimeters		Dimensions in Inches	
	Min	Max	Min	Max
A	0.900	1.200	0.035	0.047
c	0.154	0.354	0.006	0.014
D	4.800	5.400	0.190	0.213
E	5.660	6.060	0.223	0.240
D1	3.760	4.300	0.148	0.169
E1	5.900	6.350	0.232	0.250
b	0.300	0.550	0.012	0.022
k	1.100	1.500	0.043	0.059
e	1.070	1.370	0.042	0.054
E4	3.340	3.920	0.131	0.154
L	0.300	0.710	0.012	0.028
L1	-	0.120	-	0.005
H	0.400	0.710	0.016	0.028

**Order Information**

Device	Package	Marking	Carrier	Quantity
GSFP500P10	PPAK5x6	P500P10	Tape & Reel	5,000 pcs / Reel